

April 2009
UniFET<sup>TM</sup>

# FDP22N50N

# N-Channel MOSFET 500V, 22A, $0.22\Omega$

#### **Features**

- $R_{DS(on)} = 0.185\Omega$  ( Typ.)@  $V_{GS} = 10V$ ,  $I_D = 11A$
- Low gate charge (Typ. 49nC)
- Low C<sub>rss</sub> (Typ. 24pF)
- · Fast switching
- · 100% avalanche tested
- Improve dv/dt capability
- · RoHS compliant

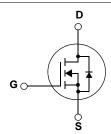


# **Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





# **MOSFET Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter			FDP22N50N	Units
V <sub>DSS</sub>	Drain to Source Voltage	Orain to Source Voltage		500	V
$V_{GSS}$	Gate to Source Voltage			±30	V
	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		22	А
'D	DrainCurrent	-Continuous (T <sub>C</sub> = 100°C)		13.2	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	88	А
E <sub>AS</sub>	Single Pulsed Avalanche Ene	ergy	(Note 2)	1000	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	22	А
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	31.25	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10	V/ns
Б	Davis Dissipation	$(T_C = 25^{\circ}C)$		312.5	W
$P_{D}$	Power Dissipation	- Derate above 25°C		2.5	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	erature Range		-55 to +150	°C
TL	Maximum Lead Temperature 1/8" from Case for 5 Seconds	• •		300	°C

<sup>\*</sup>Drain current limited by maximum junction temperature

### **Thermal Characteristics**

Symbol	Parameter	FDP22N50N	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.4	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP22N50N	FDP22N50N	TO-220	-	-	50

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V,$	500	-	-	V
ΔBV <sub>DSS</sub> / ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.45	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	1	μА
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 400V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
$I_{GSS}$	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_{D} = 11A$	•	0.185	0.22	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 20V, I <sub>D</sub> = 11A	-	24.4	-	S

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V		-	2456	3200	pF
Coss	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz		-	351	460	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112		-	24	50	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V			-	49	65	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 22A$		-	15	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V	(Note 4)	-	19	-	nC

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			-	22	55	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 250V, I_D = 22A$		-	50	110	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 4.7\Omega$		-	48	110	ns
t <sub>f</sub>	Turn-Off Fall Time		(Note 4)	-	35	80	ns

### **Drain-Source Diode Characteristics**

I <sub>S</sub>	Maximum Continuous Drain to Source Diode Forward Current		-	-	22	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	88	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 22A$	-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 22A$	-	472	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	6.5	-	μС

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 4.1mH,  $I_{AS}$  = 22A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25°C
- 3.  $I_{SD} \le 22 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25 ^{\circ} C$
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

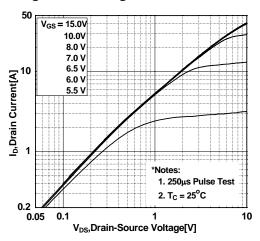


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

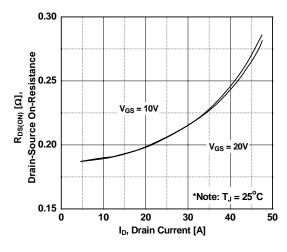


Figure 5. Capacitance Characteristics

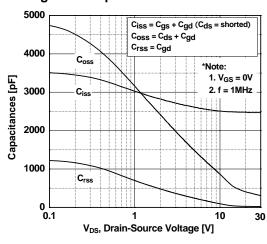


Figure 2. Transfer Characteristics

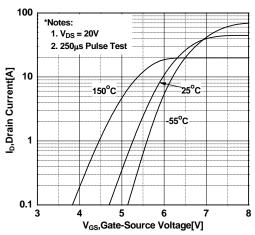


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

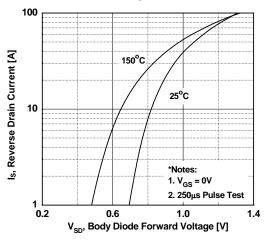
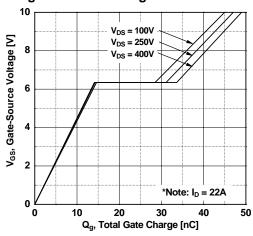


Figure 6. Gate Charge Characteristics



# **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

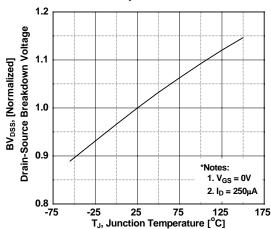


Figure 8. On-Resistance Variation vs. Temperature

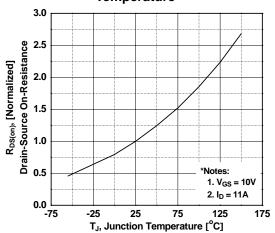


Figure 9. Maximum Safe Operating Area - FDP22N50N

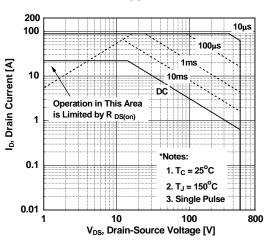


Figure 10. Maximum Drain Current vs. Case Temperature

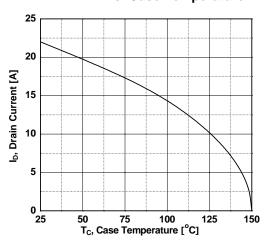
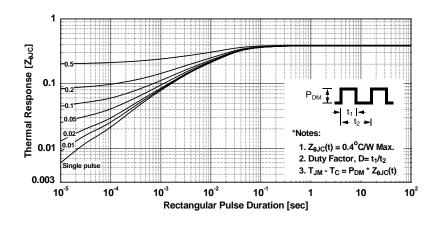
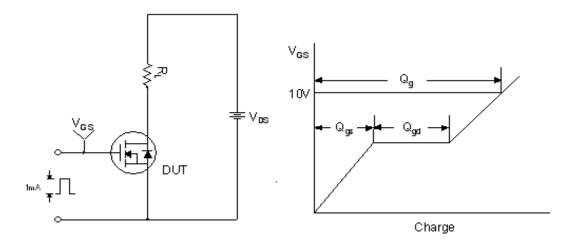


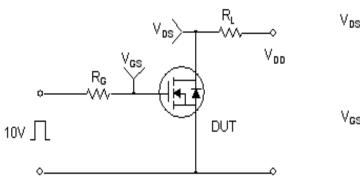
Figure 10. Transient Thermal Response Curve - FDP22N50N

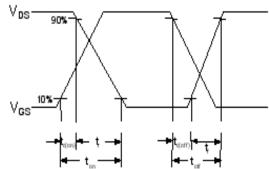


# **Gate Charge Test Circuit & Waveform**

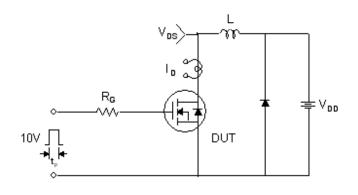


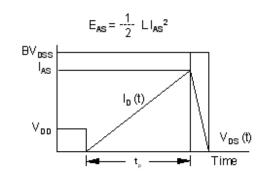
## **Resistive Switching Test Circuit & Waveforms**



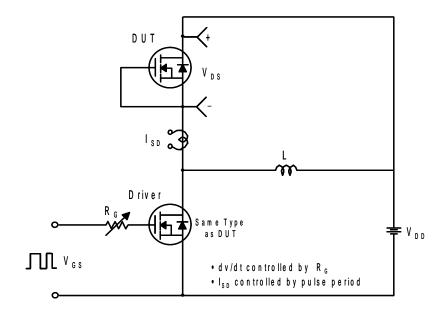


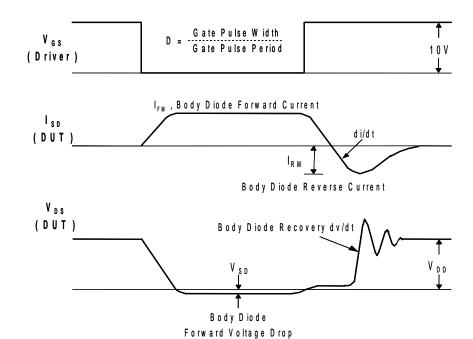
## **Unclamped Inductive Switching Test Circuit & Waveforms**





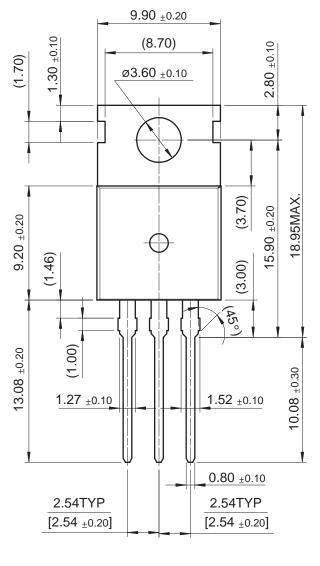
### Peak Diode Recovery dv/dt Test Circuit & Waveforms

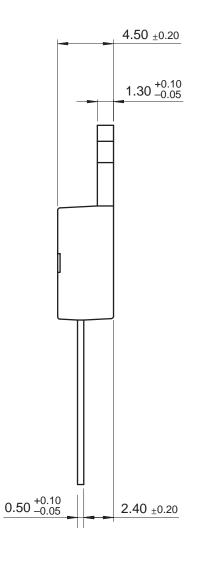


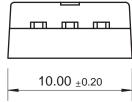


# **Mechanical Dimensions**

# TO-220











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